OSRAM LE B POMQ Datasheet

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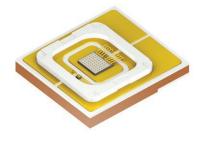




OSRAM OSTAR® Projection Power

LE B P0MQ

OSRAM OSTAR Projection Power is a high luminance LED for projection applications.





Applications

- Projection & Display

- Visualization

Features

- Package: OSTAR High Power Projection
- Chip technology: UX:3
- Typ. Radiation: 120° (Lambertian emitter)
- Color: λ_{dom} = 456 nm (• blue)
- ESD: 2 kV acc. to ANSI/ESDA/JEDEC JS-001 (HBM, Class 2)

Ordering Information

Туре	Total radiant flux ¹⁾ Ι _F = 6000 mA Φ _e	Ordering Code
LE B P0MQ-DSEQ-23	5630 8200 mW	Q65113A0547



Maximum Ratings

Parameter	Symbol		Values
Storage Temperature	T _{stg}	min.	-40 °C
		max.	100 °C
Junction Temperature	T _j	max.	150 °C
Forward Current	I _F	min.	200 mA
$T_j = T_{j,max}$	·	max.	10000 mA
Forward Current pulsed	F pulse		12000 mA
D = 0.7; f = 240 Hz; $T_j = T_{j,max}$	i puloo		
Surge Current	I _{FS}	max.	14000 mA
$t_{p} \le 50 \ \mu s; D = 0.1; T_{i} = T_{i,max}$	10		
ESD withstand voltage	V _{ESD}		2 kV
acc. to ANSI/ESDA/JEDEC JS-001 (HBM, Class 2)	230		
Reverse current ²⁾	I _R	max.	200 mA
Max. voltage difference anode-board, cathode-board	$ \Delta V_{a-b} , \Delta V_{c-b} $	max.	40 V

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Characteristics

 T_{Board} = 25 °C; I_F = 6000 mA; f = 1000 Hz; D = 0.25

Parameter	Symbol		Values
Peak Wavelength	λ_{peak}	typ.	450 nm
Dominant Wavelength 3)	λ _{dom}	min.	452 nm
	doni	typ.	456 nm
		max.	460 nm
Spectral bandwidth at 50% I _{rel,max}	Δλ	typ.	23 nm
Viewing angle at 50% I_v	2φ	typ.	120 °
Radiating surface	A _{color}	typ.	1.55 x 1.2 mm ²
Partial Flux acc. CIE 127:2007 4)	Φ _{E/V, 120°}	typ.	0.77
I _F = 6000 mA	L/V, 120		
Forward Voltage ⁵⁾	V _F	min.	3.20 V
I _F = 6000 mA	·	typ.	3.50 V
		max.	3.80 V
Reverse voltage (ESD device)	V _{RESD}	min.	45 V
Reverse voltage ²⁾	V _R	max.	1.2 V
I _R = 20 mA	TX IX		
Real thermal resistance junction/solderpoint	$R_{thJS real}$	typ.	1.6 K / W
Electrical thermal resistance junction/solderpoint with efficiency η_e = 31 %	$R_{thJS elec.}$	typ.	1.1 K / W



Brightness Groups

Group	Total radiant flux ¹⁾ I _F = 6000 mA min. Φ _e	Total radiant flux ¹⁾ I _F = 6000 mA max. Φ _e	
DS	5630 mW	6100 mW	
DT	6100 mW	6580 mW	
DU	6580 mW	7100 mW	
EP	7100 mW	7630 mW	
EQ	7630 mW	8200 mW	

Wavelength Groups

Group Dominant Wavelength ³⁾		Dominant Wavelength 3)
	min.	max.
	λ _{dom}	λ_{dom}
2	452 nm	456 nm
3	456 nm	460 nm

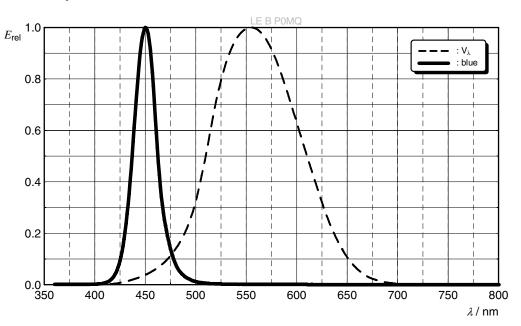
Group Name on Label

Example: DS-2 Brightness	Wavelength
DS	2



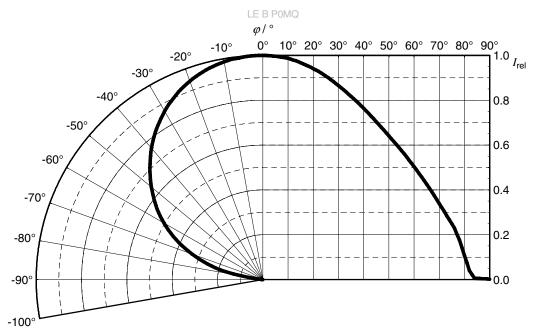
Relative Spectral Emission⁴⁾

 $E_{rel} = f(\lambda); I_{F} = 6000 \text{ mA}; T_{J} = 25 \text{ }^{\circ}\text{C}$



Radiation Characteristics⁴⁾

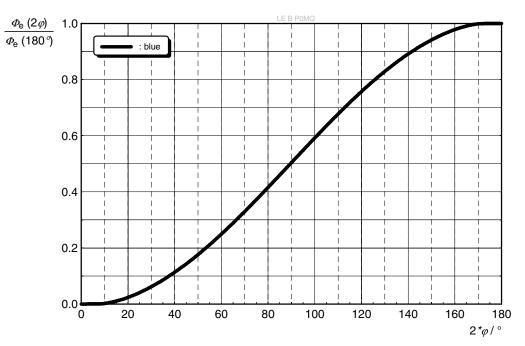
 $I_{rel} = f(\phi); T_J = 25 \ ^{\circ}C$





Relative Partial Flux⁴⁾

 $\Phi_{_{\rm E}}(2\phi)/\Phi_{_{\rm E}}(180^\circ) = f(\phi); T_{_{\rm J}} = 25 \ ^{\circ}{\rm C}$



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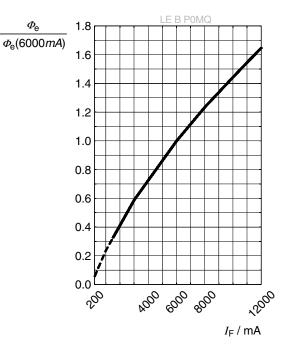


Forward current ⁴⁾

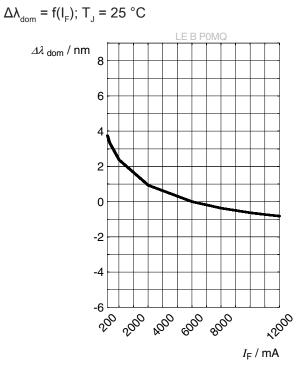
 $I_{F} = f(V_{F}); T_{J} = 25 \text{ °C}$ $I_{F} / \text{ mA} \stackrel{12000}{10000} \underbrace{I_{E} B \text{ POMO}}_{0} \underbrace{I_{E}$

Relative Radiant Power^{4), 6)}

 $\Phi_{\rm E}/\Phi_{\rm E}$ (6000 mA) = f(I_{\rm F}); T_{\rm J} = 25 °C

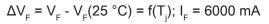


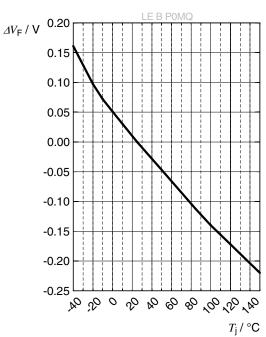
Dominant Wavelength ⁴⁾





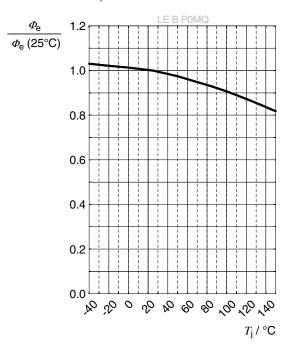
Forward Voltage ⁴⁾





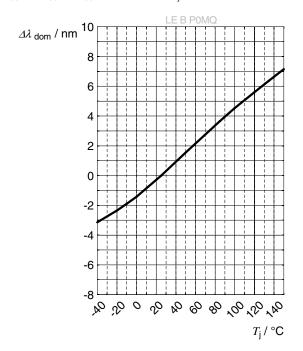
Relative Radiant Power⁴⁾

 $\Phi_{_{\rm E}}/\Phi_{_{\rm E}}(25 \ ^{\circ}{\rm C}) = f(T_{_{\rm I}}); I_{_{\rm F}} = 6000 \text{ mA}$



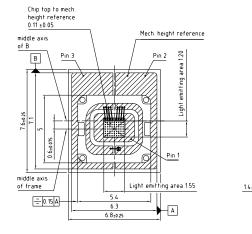
Dominant Wavelength ⁴⁾

 $\Delta \lambda_{dom} = \lambda_{dom} - \lambda_{dom} (25 \ ^{\circ}C) = f(T_j); I_F = 6000 \ mA$

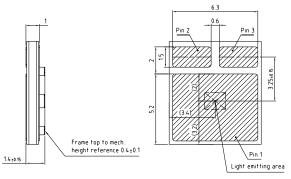




Dimensional Drawing 7)



lead finish Au ZZZ general tolerance ±0.1



Pin 1: Substrate potential, isolated from Cathode and Anode Pin 2: Anode Pin 3: Cathode

C63062-A4405-A2-04

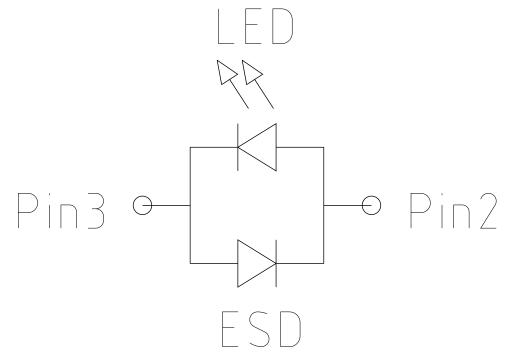
Further Information:

Approximate Weight:	380.0 mg
ESD advice:	The device is protected by ESD device which is connected in parallel to the Chip.
Notes:	Package not suitable for any kind of wet cleaning or ultrasonic cleaning.



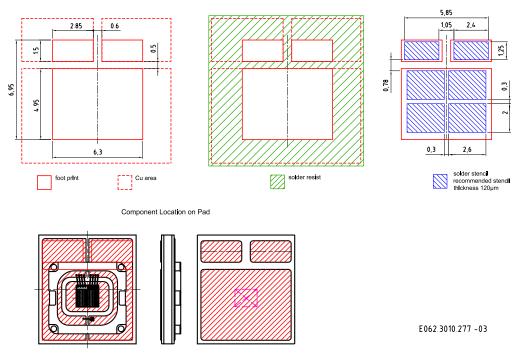


Electrical Internal Circuit





Recommended Solder Pad 7)

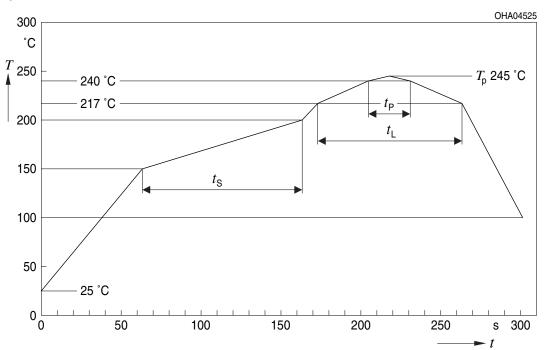


For protection during reflow soldering and handling a foil is attached to the device. The foil has to be removed before operation. For superior solder joint connectivity results we recommend soldering under standard nitrogen atmosphere. To ensure a high solder joint reliability and to minimize the risk of solder joint cracks, the customer is responsible to evaluate the combination of PCB board and solder paste material for his application.



Reflow Soldering Profile





Profile Feature	Symbol	Pb	-Free (SnAgCu) Ass	ree (SnAgCu) Assembly	
		Minimum	Recommendation	Maximum	
Ramp-up rate to preheat [•]) 25 °C to 150 °C			2	3	K/s
Time t _s T _{Smin} to T _{Smax}	t _s	60	100	120	S
Ramp-up rate to peak ^{*)} T_{smax} to T_{p}			2	3	K/s
Liquidus temperature	TL		217		°C
Time above liquidus temperature	t		80	100	S
Peak temperature	Τ _Ρ		245	260	°C
Time within 5 °C of the specified peak temperature T_{p} - 5 K	t _P	10	20	30	S
Ramp-down rate* T _P to 100 °C			3	6	K/s
Time 25 °C to T _P				480	S

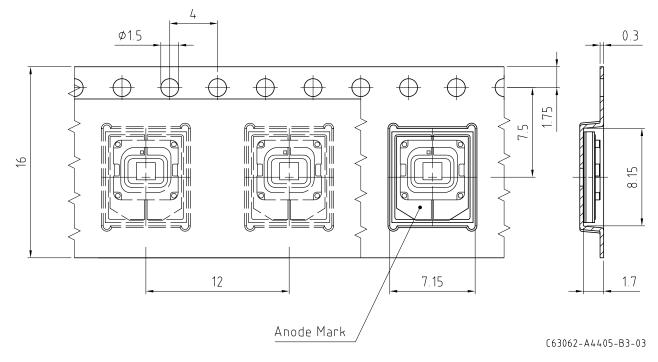
All temperatures refer to the center of the package, measured on the top of the component

 * slope calculation DT/Dt: Dt max. 5 s; fulfillment for the whole T-range

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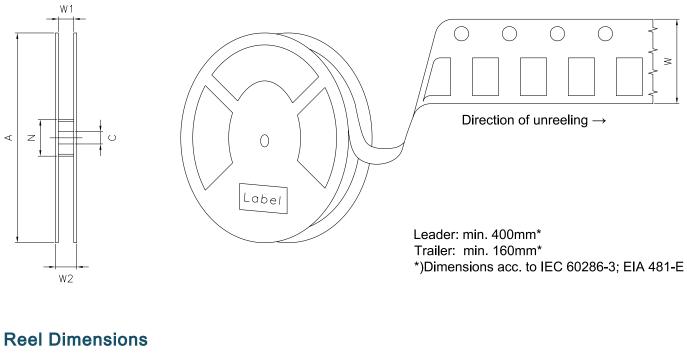
Taping 7)



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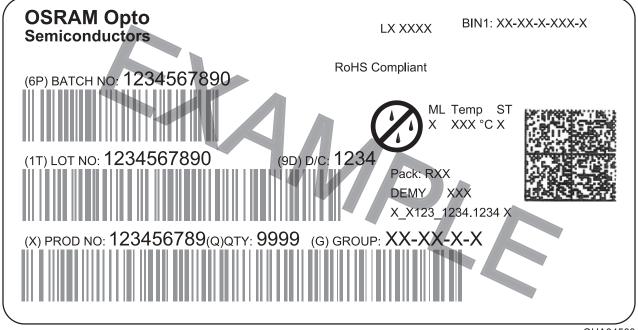
Tape and Reel⁸⁾



А	W	N _{min}	W ₁	$W_{2 \max}$	Pieces per PU
180 mm	16 + 0.3 / - 0.1 mm	60/100 mm	16.4 + 2 mm	22.4 mm	500



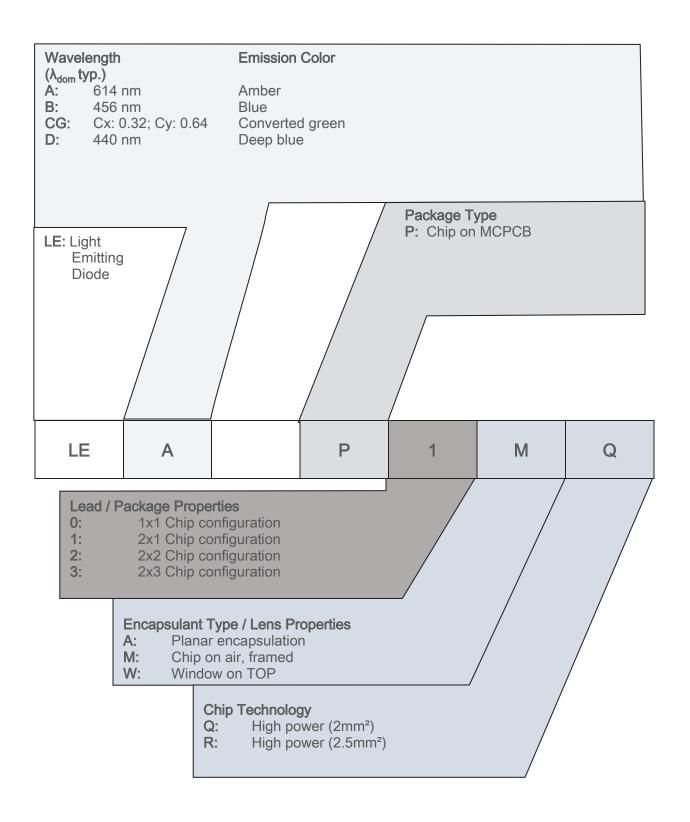
Barcode-Product-Label (BPL)



OHA04563



Type Designation System





Notes

The evaluation of eye safety occurs according to the standard IEC 62471:2006 (photo biological safety of lamps and lamp systems). Within the risk grouping system of this IEC standard, the device specified in this data sheet fall into the class **moderate risk (exposure time 0.25 s)**. Under real circumstances (for exposure time, conditions of the eye pupils, observation distance), it is assumed that no endangerment to the eye exists from these devices. As a matter of principle, however, it should be mentioned that intense light sources have a high secondary exposure potential due to their blinding effect. When looking at bright light sources (e.g. headlights), temporary reduction in visual acuity and afterimages can occur, leading to irritation, annoyance, visual impairment, and even accidents, depending on the situation.

Subcomponents of this device contain, in addition to other substances, metal filled materials including silver. Metal filled materials can be affected by environments that contain traces of aggressive substances. Therefore, we recommend that customers minimize device exposure to aggressive substances during storage, production, and use. Devices that showed visible discoloration when tested using the described tests above did show no performance deviations within failure limits during the stated test duration. Respective failure limits are described in the IEC60810.

For further application related information please visit www.osram-os.com/appnotes



Disclaimer

Attention please!

The information describes the type of component and shall not be considered as assured characteristics. Terms of delivery and rights to change design reserved. Due to technical requirements components may contain dangerous substances.

For information on the types in question please contact our Sales Organization.

If printed or downloaded, please find the latest version on our website.

Packing

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

Product and functional safety devices/applications or medical devices/applications

Our components are not developed, constructed or tested for the application as safety relevant component or for the application in medical devices.

Our products are not qualified at module and system level for such application.

In case buyer – or customer supplied by buyer – considers using our components in product safety devices/ applications or medical devices/applications, buyer and/or customer has to inform our local sales partner immediately and we and buyer and /or customer will analyze and coordinate the customer-specific request between us and buyer and/or customer.



Glossary

- ¹⁾ **Brightness:** Brightness values are measured during a pulse train of 100 ms with a pulse width of 250 μ s and a frequencey of 1 kHz, with an internal reproducibility of +/- 8 % and an expanded uncertainty of +/- 11 % (acc. to GUM with a coverage factor of k = 3). The peak brightness is calculated according to the pulse duration and frequency.
- ²⁾ Reverse Operation: This product is intended to be operated applying a forward current within the specified range. Applying any continuous reverse bias or forward bias below the voltage range of light emission shall be avoided because it may cause migration which can change the electro-optical characteristics or damage the LED.
- ³⁾ Wavelength: The wavelength is measured during a pulse train of 100 ms with a pulse width of 250 μ s and a frequencey of 1 kHz, with an internal reproducibility of ± 0,5 nm and an expanded uncertainty of ± 1 nm (acc. to GUM with a coverage factor of k=3).
- ⁴⁾ Typical Values: Due to the special conditions of the manufacturing processes of semiconductor devices, the typical data or calculated correlations of technical parameters can only reflect statistical figures. These do not necessarily correspond to the actual parameters of each single product, which could differ from the typical data and calculated correlations or the typical characteristic line. If requested, e.g. because of technical improvements, these typ. data will be changed without any further notice.
- ⁵⁾ **Forward Voltage:** The forward voltage is measured during a pulse of typical 250 μs, with an internal reproducibility of +/- 0,05 V and an expanded uncertainty of +/- 0,1 V (acc. to GUM with a coverage factor of k=3).
- ⁶⁾ **Characteristic curve:** In the range where the line of the graph is broken, you must expect higher differences between single devices within one packing unit.
- ⁷⁾ **Tolerance of Measure:** Unless otherwise noted in drawing, tolerances are specified with ±0.1 and dimensions are specified in mm.
- ⁸⁾ **Tape and Reel:** All dimensions and tolerances are specified acc. IEC 60286-3 and specified in mm.



Revision History

Version	Date	Change
1.0	2020-05-26	Initial Version
1.0	2020-05-29	Initial Version
1.1	2020-07-21	Characteristics
1.2	2021-03-19	Characteristics Ordering Information Brightness Groups Electro - Optical Characteristics (Diagrams) Tape and Reel Reel Dimensions Maximum Ratings
1.3	2022-08-01	Dimensional Drawing Taping New Layout Applications



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